TJF1441

High-speed CAN transceiver

Rev. 2 — 15 October 2021

Product data sheet

1 General description

The TJF1441 is a member of the TJA144x family of transceivers that provide an interface between a Controller Area Network (CAN) or CAN FD (Flexible Data rate) protocol controller and the physical two-wire CAN bus. TJA144x transceivers implement the CAN physical layer as defined in ISO 11898-2:2016 and SAE J2284-1 to SAE J2284-5, and are fully interoperable with high-speed Classical CAN and CAN FD transceivers. All TJA144x variants enable reliable communication in the CAN FD fast phase at data rates up to 5 Mbit/s.

The TJF1441 is designed for CAN industrial applications allowing networks to run at very low bit rates up to 5 Mbit/s CAN-FD. A VIO supply input allows for direct interfacing with 3.3 V and 5 V-supplied microcontrollers. It is intended as a replacement for high-speed Classical CAN and CAN FD transceivers, such as the TJF1051 from NXP. It offers pin compatibility and is designed to avoid changes to hardware and software design, allowing the TJF1441 to be easily retrofitted to existing applications.

A variant intended for high-speed CAN applications in the automotive industry, the TJA1441, is also available.

2 Features and benefits

2.1 General

- ISO 11898-2:2016, SAE J2284-1 to SAE J2284-5 and SAE J1939-14 compliant
- Standard CAN and CAN FD data bit rates up to 5 Mbit/s
- · Optimized for industrial applications
- Low Electromagnetic Emission (EME) and high Electromagnetic Immunity (EMI)
- Silent mode for node diagnosis and failure containment
- VIO input for interfacing with 3.3 V to 5 V microcontrollers
- · Available in SO8 package
- Dark green product (halogen free and Restriction of Hazardous Substances (RoHS) compliant)

2.2 Predictable and fail-safe behavior

- Undervoltage detection with defined handling on all supply pins
- Full functionality guaranteed from the undervoltage detection thresholds up to the maximum limiting voltage values
- · Defined behavior below the undervoltage detection thresholds
- Transceiver disengages from the bus (high-ohmic) when the supply voltage drops below the Off mode threshold
- Internal biasing of TXD and mode selection input pin, to enable defined fail-safe behavior



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2.3 Protection

- High ESD handling capability on the bus pins (8 kV IEC and HBM)
- Thermally protected

3 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		4.5	-	5.5	V
I _{CC}	supply current	Normal mode, dominant	-	38	60	mA
		Normal mode, recessive	-	4	7	mA
		Silent mode	-	3	6	mA
V _{uvd(VCC)}	undervoltage detection voltage on pin VCC		4	-	4.5	V
V _{uvhys(VCC)}	undervoltage hysteresis voltage on pin VCC		50	-	-	mV
V _{IO}	supply voltage on pin VIO		2.95	-	5.5	V
I _{IO}	supply current on pin VIO	Normal mode, dominant; V _{TXD} = 0 V	-	250	760	μΑ
		Normal mode, recessive; V _{TXD} = V _{IO}	-	150	460	μΑ
		Silent mode; V _{TXD} = V _{IO}	-	70	200	μΑ
V _{uvd(swoff)(VIO)}	switch-off undervoltage detection voltage on pin VIO		2.65	-	2.95	V
V _{ESD}	electrostatic discharge voltage	IEC 61000-4-2 on pins CANH and CANL	-8	-	+8	kV
V _{CANH}	voltage on pin CANH	limiting value according to IEC 60134	-36	-	+40	V
V _{CANL}	voltage on pin CANL	limiting value according to IEC 60134	-36	-	+40	V
T_{vj}	virtual junction temperature		-40	-	+150	°C

4 Ordering information

Table 2. Ordering information

Type number	Package							
	Name	Description Version						
TJF1441AT	SO8	plastic small outline package; 8 leads; body width 3.9 mm	SOT96-1					

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Table 3. TJF1441 feature overview

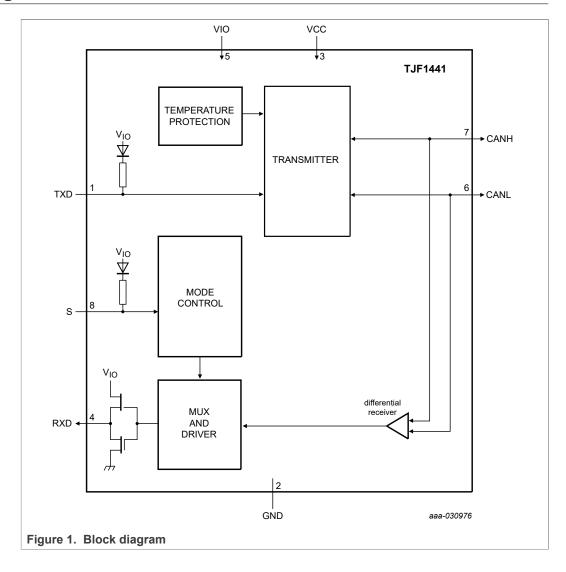
See Section 18 for a feature overview of the complete TJx144x/TJx146x/TJF1441 family.

	Mod	es				Supp	lies		Data	rate	Addit	ional	feature	s		
Device ^[1]	Normal	Standby	Sleep	Silent/Listen-only	Selectable Off	VCC pin	VIO pin	VBAT pin	Up to 5 Mbit/s CAN FD	Up to 8 Mbit/s CAN FD	Signal improvement ^[2]	Wake-up source recognition ^[3]	Short WUP support [0.5 - 1.8 µs] ^[4]	Single supply pin wake-up	TXD dominant timeout	Local diagnostics via ERR_N pin
TJF1441A	•			•		•	•		•						[5]	

- TJF1441 is AEC-Q100 Grade 1.
- CAN FD Signal Improvement Capability (SIC) according to CiA 601-4:2019.
- RXD is held LOW after wake-up request, enabling wake-up source recognition. WUP = wake-up pattern according ISO11898-2:2016.
- [1] [2] [3] [4] [5] Not having TXD dominant timeout allows for very low data rates in non-automotive grade applications.

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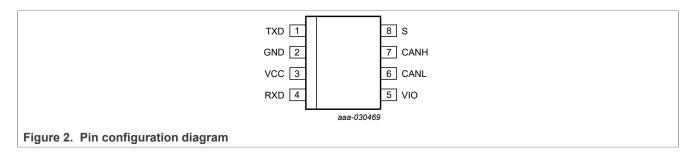
5 Block diagram



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6 Pinning information

6.1 Pinning



6.2 Pin description

Table 4. Pin description

Symbol	Pin	Type ^[1]	Description
TXD	1	I	transmit data input; inputs data (from the CAN controller) to be written to the bus lines
GND	2	G	ground
VCC	3	Р	5 V supply voltage input
RXD	4	0	receive data output; outputs data read from the bus lines (to the CAN controller).
VIO	5	Р	supply voltage for I/O level adapter
CANL	6	AIO	LOW-level CAN bus line
CANH	7	AIO	HIGH-level CAN bus line
S	8	ı	Silent mode control input

^[1] I: digital input; O: digital output; AIO: analog input/output; P: power supply; G: ground.

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7 Functional description

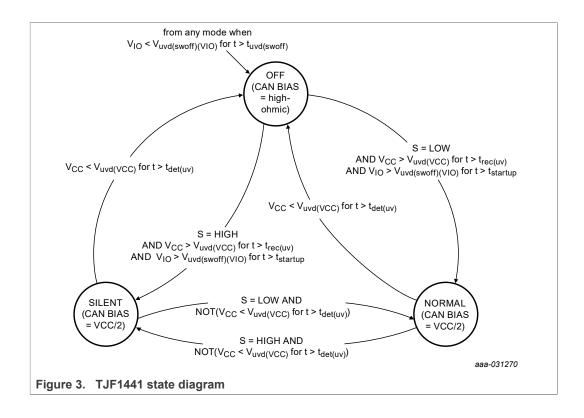
7.1 Operating modes

The TJF1441 supports three operating modes, Normal, Silent, and Off. The operating mode is selected via pin S. See <u>Table 5</u> for a description of the operating modes under normal supply conditions. Mode changes are completed after transition time $\underline{t}_{t(moch)}$.

Table 5. Operating modes

Mode	Inputs		Outputs	
	Pin S	Pin TXD	CAN driver	Pin RXD
Normal	LOW	LOW dominant		LOW
		HIGH	recessive	LOW when bus dominant
				HIGH when bus recessive
Silent	HIGH	Х	biased to V _{CC} /2	LOW when bus dominant
				HIGH when bus recessive
Off ^[1]	X	X	high-ohmic state	high-ohmic state

^[1] Off mode is only entered when the voltage on pin VCC is below V_{uvd(VCC)} or the voltage on pin VIO is below V_{uvd(swoff)VIO} (see <u>Figure 3</u>).



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7.1.1 Off mode

The TJF1441 switches to Off mode from any mode when the supply voltage on pin VIO falls below the switch-off undervoltage detection threshold ($V_{uvd(swoff)(VIO)}$) or when V_{CC} drops below $V_{uvd(VCC)}$. This is the default mode when the supply is first connected.

The CAN pins and pin RXD are in a high-ohmic state in Off mode.

When the supply voltage rises above the switch-off undervoltage detection threshold, the TJF1441 starts to boot up, triggering an initialization procedure. It switches to the selected mode after $\underline{t}_{\text{startup}}$, provided $V_{\text{CC}} > V_{\text{uvd}(\text{VCC})}$.

7.1.2 Silent mode

A HIGH level on pin S selects Silent mode. The transmitter is disabled in Silent mode, releasing the bus pins to $V_{\rm CC}/2$. All other IC functions, including the receiver, continue to operate as in Normal mode. Silent mode can be used to prevent a faulty CAN controller disrupting network communications.

7.1.3 Normal mode

A LOW level on pin S selects Normal mode. In Normal mode, the transceiver can transmit and receive data via bus lines CANH and CANL. Pin TXD must be HIGH at least once in Normal mode before transmission can begin. The differential receiver converts the analog data on the bus lines into digital data on pin RXD. The slopes of the output signals on the bus lines are controlled internally and are optimized in a way that guarantees the lowest possible EME. In recessive state, the output voltage on the bus pins is $V_{\rm CC}/2$.

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7.1.4 Operating modes and gap-free operation

Gap-free operation guarantees defined behavior at all voltage levels. Supply voltage-to-operating mode mapping is detailed in <u>Figure 4</u> and in the state diagram (<u>Figure 3</u>).

	5.5 V - 6 V ^[1]			Fully functional ^{[2][3}	[3]	
e on VCC	V _{CC} operating range (4.5 V - 5.5 V)		Fully functional ^{[2][3]} OR Off ^[4]	Fully functional ^[2] and characteristics guaranteed ^[5]		
Voltage range on VCC	V _{uvd(VCC)} range ^[6]	Off	Fully functional ^[2] OR Off ^[4]	Fully functional ^[2] OR Off ^[4]		
Volt	-0.3 V - 4 V		Off ^[4]	Off		
		-0.3 V - 2.65 V	V _{uvd(swoff)(VIO)} range ^[6]	V _{IO} operating range (2.95 V - 5.5 V)	5.5 V - 6 V[1]	
			Voltage ra	inge on VIO		

- [1] 6 V is the IEC 60134 Absolute Maximum Rating (AMR) for VCC and VIO (see Limiting values table). Above the AMR, irreversible changes in characteristics, functionality or performance may occur. Returning from above AMR to the operating range, datasheet characteristics and functionality cannot be guaranteed.
- [2] Target transceiver functionality as described in this datasheet is applicable.
- [3] Prolonged operation of the device outside the operating range may impact reliability over lifetime. Returning to the operating range, datasheet characteristics are guaranteed provided the AMR has not been exceeded.
- [4] For a given value of V_{CC} or V_{IO} , a specific device will be in a single defined state determined by its undervoltage detection thresholds $(V_{uvd}(V_{CC}))$ and $V_{uvd}(S_{uvd}(V_{CC}))$. The actual thresholds can vary between devices (within the ranges specified in this data sheet). To guarantee the device will be in a specific state, V_{IO} and V_{CC} must be either above the maximum or below the minimum thresholds specified for these undervoltage detection ranges.
- [5] Datasheet characteristics are guaranteed within the V_{CC} and V_{IO} operating ranges. Exceptions are described in the Static and Dynamic characteristics tables.
- [6] The device is fully functional when both V_{CC} and V_{IO} are above the undervoltage threshold. If V_{CC} or V_{IO} falls below any undervoltage threshold, the device switches to Off mode.

aaa-038711

Figure 4. Supply voltage ranges and gap-free operation

7.2 Fail-safe features

7.2.1 Internal biasing of TXD and S input pins

Pins TXD and S have internal pull-ups to VIO to ensure a safe, defined state in case one or more of these pins is left open or become floating. Pull-up resistors are active on these pins in all states; they should be held at the V_{IO} level in Silent mode to minimize supply current.

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7.2.2 Undervoltage detection on pins VCC and VIO

If V_{CC} or V_{IO} drops below the undervoltage detection threshold ($V_{uvd(VCC)}$ or $V_{uvd(swoff)VIO}$) the transceiver switches to Off mode and disengages from the bus (zero load; bus pins high-ohmic) until the supply voltage has recovered. If Normal mode is selected, the output drivers are enabled once both V_{CC} and V_{IO} are again within their operating ranges and TXD has been reset to HIGH.

7.2.3 Overtemperature protection

The device is protected against overtemperature conditions. If the junction temperature exceeds the shutdown junction temperature, $T_{j(sd)}$, the CAN bus drivers are disabled. When the junction temperature drops below $T_{j(sd)rel}$, the CAN bus drivers recover once TXD has been reset to HIGH and Normal mode is selected (waiting for TXD to go HIGH prevents output driver oscillation due to small variations in temperature).

7.2.4 VIO supply pin

Pin VIO should be connected to the microcontroller supply voltage (see <u>Figure 8</u>). This adjusts the signal levels on pins TXD, RXD and S to the I/O levels of the microcontroller, allowing for direct interfacing without additional glue logic. Spurious signals from the microcontroller on pin S are filtered out with a filter time of $\underline{t}_{fltr(IO)}$.

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Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134); all voltages are referenced to pin GND, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Max	Unit
V _x	voltage on pin x ^[1]	on pins VCC, VIO, TXD, S		-0.3	+6	V
				-	+7 ^[2]	
		on pins CANH, CANL		-36	+40	V
		on pins RXD		-0.3	V _{IO} +0.3 ^[3]	
V _(CANH-CANL)	voltage between pin CANH and pin CANL			-40	+40	V
V _{trt}	transient voltage	on pins CANH, CANL	[4]			
		pulse 1		-100	-	V
		pulse 2a		-	+75	V
		pulse 3a		-150	-	V
		pulse 3b		-	+100	V
V _{ESD}	electrostatic discharge	IEC 61000-4-2 (150 pF, 330 Ω discharge circuit)	[5]			
	voltage	on pins CANH, CANL		-8	+8	kV
		Human Body Model (HBM)				
		on any pin	[6]	-4	+4	kV
		on pins CANH, CANL	[7]	-8	+8	kV
		Charged Device Model (CDM)	[8]			
		on corner pins		-750	+750	V
		on any other pin		-500	+500	V
T _{vj}	virtual junction temperature		[9]	-40	+150	°C
T _{stg}	storage temperature		[10]	-55	+150	°C

^[1] The device can sustain voltages up to the specified values over the product lifetime, provided applied voltages (including transients) never exceed these

- The device can withstand voltages between 6 V and 7 V for a total of 20 s over the product lifetime.
- Subject to the qualifications detailed in Table notes 1 and 2 above for pins VCC, VIO, TXD, and S.

 Verified by an external test house according to IEC TS 62228, Section 4.2.4; parameters for standard pulses defined in ISO7637.
- Verified by an external test house according to IEC TS 62228, Section 4.3.
- According to AEC-Q100-002.
- Pins stressed to reference group containing all ground and supply pins, emulating the application circuit (Figure 8). HBM pulse as specified in AEC-Q100-002 used.
- According to AEC-Q100-011.
- [9] In accordance with IEC 60747-1. An alternative definition of virtual junction temperature is: T_{vj} = T_{amb} + P # R_{th(j-a)}, where R_{th(j-a)} is a fixed value used in the calculation of T_{vj}. The rating for T_{vj} limits the allowable combinations of power dissipation (P) and ambient temperature (T_{amb}).
 [10] T_{stg} in application according to IEC61360-4. For component transport and storage conditions, see instead IEC61760-2.

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9 Thermal characteristics

Table 7. Thermal characteristics

Value determined for free convection conditions on a JEDEC 2S2P board.

Symbol	Parameter	Conditions ^[1]	Тур	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient		96	K/W
$\Psi_{j\text{-top}}$	thermal characterization parameter from junction to top of package		9	K/W

^[1] According to JEDEC JESD51-2, JESD51-5 and JESD51-7 at natural convection on 2s2p board. Board with two inner copper layers (thickness: 35 μm) and thermal via array under the exposed pad connected to the first inner copper layer (thickness: 70 μm).

10 Static characteristics

Table 8. Static characteristics

 T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V (TJF1441A); R_L = 60 Ω ; unless specified otherwise; all voltages are defined with respect to ground; positive currents flow into the IC. [1]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Supply; pin \	VCC	,			'	
V _{CC}	supply voltage		4.5	-	5.5	V
V _{uvd}	undervoltage detection voltage	[2]	4	-	4.5	V
V _{uvhys}	undervoltage hysteresis voltage		50	-	-	mV
I _{CC}	supply current	Normal mode				
		dominant; V _{TXD} = 0 V	-	38	60	mA
		dominant; V _{TXD} = 0 V; short circuit on bus lines; -3 V < (V _{CANH} = V _{CANL}) < +40 V	-	-	125	mA
		recessive; V _{TXD} = V _{IO}	-	4	7	mA
		Silent mode; V _{TXD} = V _{IO}	-	3	6	mA
I/O level ada	apter supply; pin VIO		'	'	,	
V _{IO}	supply voltage		2.95	-	5.5	V
V _{uvd(swoff)}	switch-off undervoltage detection voltage	[2]	2.65	-	2.95	V
I _{IO}	supply current	Normal mode; dominant; V _{TXD} = 0 V	-	250	760	μΑ
		Normal mode; recessive; V _{TXD} = V _{IO}	-	150	460	μΑ
		Silent mode; V _{TXD} = V _{IO}	-	70	200	μA
CAN transn	nit data input; pin TXD					
V _{IH}	HIGH-level input voltage		0.7V _{IO}	-	-	V
V _{IL}	LOW-level input voltage		-	-	0.3V _{IO}	V
$V_{hys(TXD)}$	hysteresis voltage on pin TXD		50	-	-	mV
R _{pu}	pull-up resistance		20	-	80	kΩ

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Table 8. Static characteristics...continued

 T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V (TJF1441A); R_L = 60 Ω ; unless specified otherwise; all voltages are defined with respect to ground; positive currents flow into the IC. [1]

Cumbal	Parameter .	Conditions		Min	Tire	Max	110:4
Symbol	Parameter	Conditions	[3]	Min	Тур	Max	Unit
C _i	input capacitance		اما	-	-	10	pF
CAN receive	e data output; pin RXD						
I _{OH}	HIGH-level output current	$V_{RXD} = V_{IO} - 0.4 V$		-10	-	-1	mA
I _{OL}	LOW-level output current	V _{RXD} = 0.4 V		+1	-	+10	mA
Silent contr	ol inputs; pins S						
V_{IH}	HIGH-level input voltage			0.7V _{IO}	-	-	V
V_{IL}	LOW-level input voltage			-	-	0.3V _{IO}	V
V _{hys}	hysteresis voltage			50	-	-	mV
R _{pu}	pull-up resistance			20	-	80	kΩ
C _i	input capacitance		[3]	-	-	10	pF
Bus lines; pii	ns CANH and CANL						
V _{O(dom)}	dominant output voltage	V _{TXD} = 0 V; V _{CC} ≥ 4.75 V					
		pin CANH; R _L = 50 Ω to 65 Ω		2.75	3.5	4.5	V
		pin CANL; R_L = 50 Ω to 65 Ω		0.5	1.5	2.25	V
V_{TXsym}	transmitter voltage symmetry	$V_{TXsym} = V_{CANH} + V_{CANL};$ $C_{SPLIT} = 4.7 \text{ nF};$ $f_{TXD} = 250 \text{ kHz}, 1 \text{ MHz or } 2.5 \text{ MHz}$	[3] [4]	0.9V _{CC}	-	1.1V _{CC}	V
V _{cm(step)}	common mode voltage step		[3] [4] [5]	-150	-	+150	mV
V _{cm(p-p)}	peak-to-peak common mode voltage		[3] [4] [5]	-300	-	+300	mV
V _{O(dif)}	differential output voltage	dominant; Normal mode; V _{TXD} = 0 V; V _{CC} ≥ 4.75 V					
		R_L = 50 Ω to 65 Ω		1.5	-	3	V
		R_L = 45 Ω to 70 Ω		1.4	-	3.3	V
		R _L = 2240 Ω	[3]	1.5	-	5	V
		recessive; no load					
		Normal or Silent mode; V _{TXD} = V _{IO}		-50	-	+50	mV
V _{O(rec)}	recessive output voltage	Normal or Silent mode; V _{TXD} = V _{IO} ; no load		2	2.5	3	V
$V_{th(RX)dif}$	differential receiver threshold voltage	Normal or Silent mode; -12 V \leq V _{CANH} \leq +12 V; -12 V \leq V _{CANL} \leq +12 V		0.5	-	0.9	V
V _{rec(RX)}	receiver recessive voltage	Normal or Silent mode; -12 V \leq V _{CANH} \leq +12 V; -12 V \leq V _{CANL} \leq +12 V		-4	-	0.5	V

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Table 8. Static characteristics...continued

 T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V (TJF1441A); R_L = 60 Ω ; unless specified otherwise; all voltages are defined with respect to ground; positive currents flow into the IC.^[1]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{\text{dom}(RX)}$	receiver dominant voltage	Normal or Silent mode; $-12 \text{ V} \le \text{V}_{\text{CANH}} \le +12 \text{ V}$; $-12 \text{ V} \le \text{V}_{\text{CANL}} \le +12 \text{ V}$	0.9	-	9	V
V _{hys(RX)dif}	differential receiver hysteresis voltage	Normal or Silent mode; -12 $V \le V_{CANH} \le +12 V$; -12 $V \le V_{CANL} \le +12 V$	50	-	-	mV
I _{O(sc)}	short-circuit output current	-15 V ≤ V _{CANH} ≤ +40 V; -15 V ≤ V _{CANL} ≤ +40 V	-	-	115	mA
I _{O(sc)rec}	recessive short-circuit output current	Normal mode; $V_{TXD} = V_{IO}$; -27 $V \le V_{CANH} \le +32 V$; -27 $V \le V_{CANL} \le +32 V$	-3	-	+3	mA
I _L	leakage current	$V_{CC} = V_{IO} = 0 \text{ V or pins shorted to GND}$ via 47 K Ω ; $V_{CANH} = V_{CANL} = 5 \text{ V}$;	-10	-	+10	μA
R _i	input resistance	-2 V ≤ V _{CANL} ≤ +7 V; -2 V ≤ V _{CANH} ≤ +7 V	25	40	50	kΩ
ΔR_i	input resistance deviation	$0 \text{ V} \le \text{V}_{CANL} \le +5 \text{ V}; 0 \text{ V} \le \text{V}_{CANH} \le +5 \text{ V}$	-3	-	+3	%
R _{i(dif)}	differential input resistance	-2 V ≤ V _{CANL} ≤ +7 V; -2 V ≤ V _{CANH} ≤ +7 V	50	80	100	kΩ
C _{i(cm)}	common-mode input capacitance	[3]	-	-	20	pF
C _{i(dif)}	differential input capacitance	[3]	-	-	10	pF
Temperature	e detection				,	
$T_{j(sd)}$	shutdown junction temperature		180	-	200	°C
T _{j(sd)rel}	release shutdown junction temperature		175	-	195	°C

^[1] All parameters are guaranteed over the virtual junction temperature range by design. Factory testing uses correlated test conditions to cover the specified temperature and power supply voltage ranges.

^[2] Undervoltage is detected between min and max values. Undervoltage is guaranteed to be detected below min value and guaranteed not to be detected above max value.

^[3] Not tested in production; guaranteed by design.

The test circuit used to measure the bus output voltage symmetry (which includes C_{SPLIT}) is shown in Figure 9.

^[5] See <u>Figure 7</u>

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11 Dynamic characteristics

Table 9. Dynamic characteristics

 T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V (TJF1441A); R_L = 60 Ω ; unless specified otherwise; all voltages are defined with respect to ground. [1]

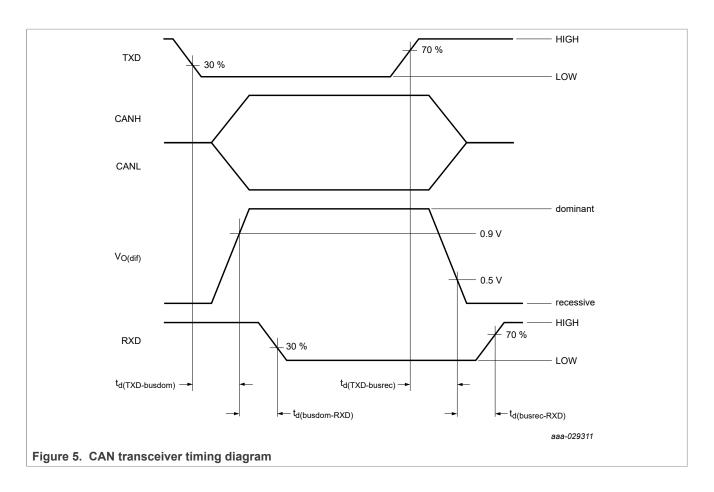
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
CAN timing ch	naracteristics; t _{bit(TXD)} ≥ 200 ns; see <u>Figure</u>	5, Figure 6 and Figure 9				'	
t _{d(TXD-busdom)}	delay time from TXD to bus dominant	Normal mode		_	-	102.5	ns
t _{d(TXD-busrec)}	delay time from TXD to bus recessive	Normal mode		-	-	102.5	ns
t _{d(busdom-RXD)}	delay time from bus dominant to RXD	Normal or Silent mode		-	-	115	ns
t _{d(busrec-RXD)}	delay time from bus recessive to RXD	Normal or Silent mode		_	-	115	ns
$t_{d(TXDL-RXDL)}$	delay time from TXD LOW to RXD LOW	Normal mode		-	-	215	ns
t _{d(TXDH-RXDH)}	delay time from TXD HIGH to RXD HIGH	Normal mode		-	-	215	ns
CAN FD timin	g characteristics; see Figure 6 and Figure	9			'	'	
t _{bit(bus)}	transmitted recessive bit width	$t_{bit(TXD)}$ = 500 ns		435	-	530	ns
		$t_{bit(TXD)}$ = 200 ns		155	-	210	ns
t _{bit(RXD)}	bit time on pin RXD	$t_{bit(TXD)}$ = 500 ns		400	-	550	ns
		t _{bit(TXD)} = 200 ns		120	-	220	ns
Δt_{rec}	receiver timing symmetry	$t_{bit(TXD)} = 500 \text{ ns}$		-65	-	40	ns
		t _{bit(TXD)} = 200 ns		-45	-	15	ns
Mode transition	ons				·		
t(moch)	mode change transition time		[2]	_	-	50	μs
<u>t</u> startup	start-up time		[2]	-	-	1	ms
IO filter; pins	S				-	'	
t _{fitr(IO)}	I/O filter time		[3]	1	-	5	μs
Undervoltage	detection; see Figure 3						
t _{det(uv)}	undervoltage detection time	on pin VCC	[2]	-	-	30	μs
t _{uvd(swoff)}	switch-off undervoltage detection time	on pin VIO	[2]	-	-	30	μs
t _{rec(uv)}	undervoltage recovery time	on pin VCC	[2]	-	-	50	μs

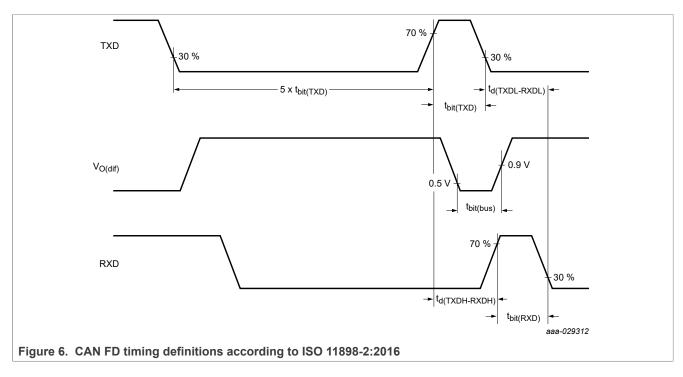
^[1] All parameters are guaranteed over the junction temperature range by design. Factory testing uses correlated test conditions to cover the specified temperature and power supply voltage ranges.

^[2] Not tested in production; guaranteed by design.

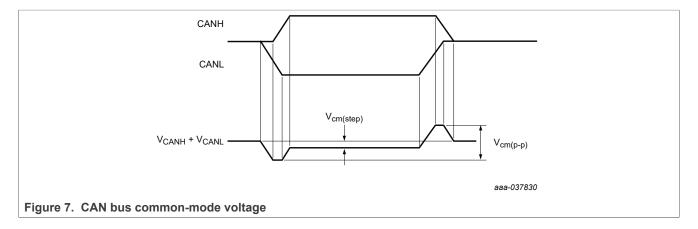
^[3] Pulses shorter than the min value are guaranteed to be filtered out; pulses longer than the max value are guaranteed to be processed.

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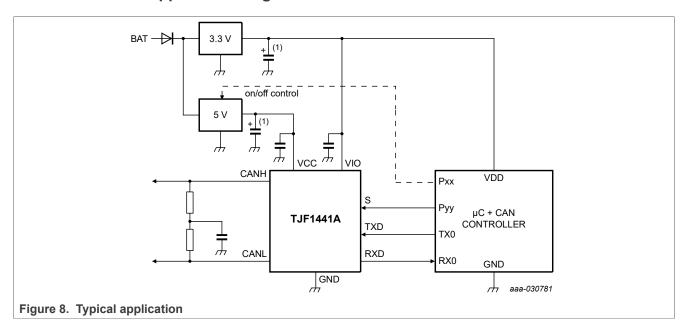


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12 Application information

12.1 Application diagram

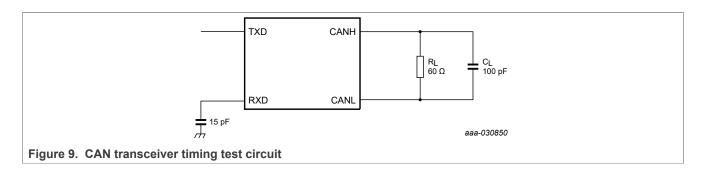


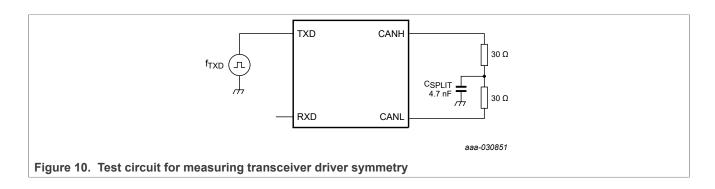
12.2 Application hints

Further information on the application of the TJF1441 can be found in NXP application hints AH2002 'TJx144x/TJx146x Application Hints', available on request from NXP Semiconductors.

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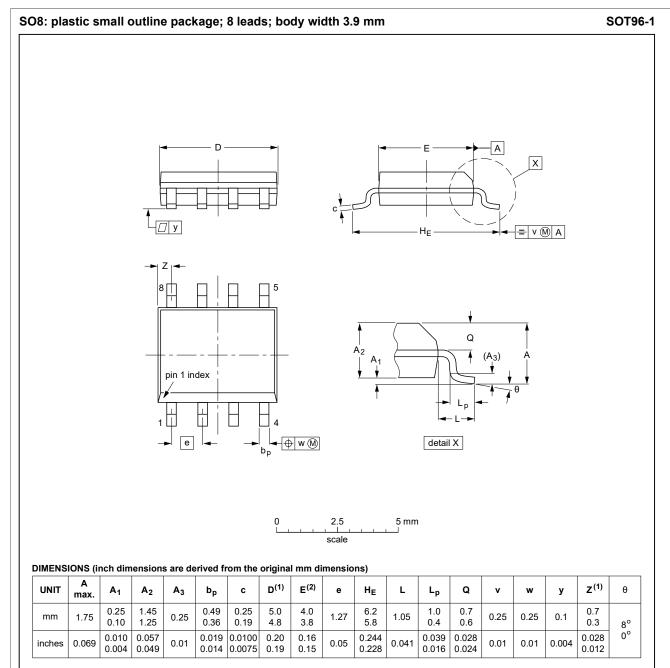
13 Test information





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14 Package outline



Notes

- 1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.
- 2. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

OUTLINE		EUROPEAN	ISSUE DATE				
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT96-1	076E03	MS-012				99-12-27 03-02-18	

Figure 11. Package outline SOT96-1 (SO8)

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15 Handling information

All input and output pins are protected against ElectroStatic Discharge (ESD) under normal handling. When handling ensure that the appropriate precautions are taken as described in *JESD625-A* or equivalent standards.

16 Soldering of SMD packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering ICs can be found in Application Note *AN10365 "Surface mount reflow soldering description"*.

16.1 Introduction to soldering

Soldering is one of the most common methods through which packages are attached to Printed Circuit Boards (PCBs), to form electrical circuits. The soldered joint provides both the mechanical and the electrical connection. There is no single soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and Surface Mount Devices (SMDs) are mixed on one printed wiring board; however, it is not suitable for fine pitch SMDs. Reflow soldering is ideal for the small pitches and high densities that come with increased miniaturization.

16.2 Wave and reflow soldering

Wave soldering is a joining technology in which the joints are made by solder coming from a standing wave of liquid solder. The wave soldering process is suitable for the following:

- Through-hole components
- Leaded or leadless SMDs, which are glued to the surface of the printed circuit board

Not all SMDs can be wave soldered. Packages with solder balls, and some leadless packages which have solder lands underneath the body, cannot be wave soldered. Also, leaded SMDs with leads having a pitch smaller than ~0.6 mm cannot be wave soldered, due to an increased probability of bridging.

The reflow soldering process involves applying solder paste to a board, followed by component placement and exposure to a temperature profile. Leaded packages, packages with solder balls, and leadless packages are all reflow solderable.

Key characteristics in both wave and reflow soldering are:

- · Board specifications, including the board finish, solder masks and vias
- · Package footprints, including solder thieves and orientation
- · The moisture sensitivity level of the packages
- · Package placement
- · Inspection and repair
- · Lead-free soldering versus SnPb soldering

16.3 Wave soldering

Key characteristics in wave soldering are:

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- Process issues, such as application of adhesive and flux, clinching of leads, board transport, the solder wave parameters, and the time during which components are exposed to the wave
- · Solder bath specifications, including temperature and impurities

16.4 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see <u>Figure 12</u>) than a SnPb process, thus reducing the process window
- Solder paste printing issues including smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board
 is heated to the peak temperature) and cooling down. It is imperative that the peak
 temperature is high enough for the solder to make reliable solder joints (a solder
 paste characteristic). In addition, the peak temperature must be low enough that the
 packages and/or boards are not damaged. The peak temperature of the package
 depends on package thickness and volume and is classified in accordance with
 Table 10 and Table 11

Table 10. SnPb eutectic process (from J-STD-020D)

Package thickness (mm)	Package reflow temperature (°C)					
	Volume (mm³)					
	< 350	≥ 350				
< 2.5	235	220				
≥ 2.5	220	220				

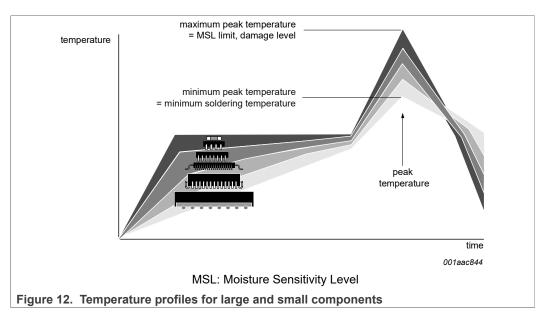
Table 11. Lead-free process (from J-STD-020D)

Package thickness (mm)	Package reflow temperature (°C)						
	Volume (mm³)						
	< 350	350 to 2000	> 2000				
< 1.6	260	260	260				
1.6 to 2.5	260	250	245				
> 2.5	250	245	245				

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see Figure 12.

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For further information on temperature profiles, refer to Application Note *AN10365* "Surface mount reflow soldering description".

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17 Appendix: ISO 11898-2:2016 parameter cross-reference list

Table 12. ISO 11898-2:2016 to NXP data sheet parameter conversion

ISO 11898-2:2016		NXP data sheet			
Parameter	Notation	Symbol	Parameter		
HS-PMA dominant output characteristics					
Single ended voltage on CAN_H	V _{CAN_H}	$V_{O(dom)}$	dominant output voltage		
Single ended voltage on CAN_L	V _{CAN_L}				
Differential voltage on normal bus load	V _{Diff}	V _{O(dif)}	differential output voltage		
Differential voltage on effective resistance during arbitration					
Optional: Differential voltage on extended bus load range					
HS-PMA driver symmetry		-			
Driver symmetry	V _{SYM}	V_{TXsym}	transmitter voltage symmetry		
Maximum HS-PMA driver output current					
Absolute current on CAN_H	I _{CAN_H}	I _{O(sc)dom}	dominant short-circuit output		
Absolute current on CAN_L	I _{CAN_L}		current		
HS-PMA recessive output characteristics, bus biasing ac	tive/inacti	ve			
Single ended output voltage on CAN_H	V _{CAN_H}	V _{O(rec)}	recessive output voltage		
Single ended output voltage on CAN_L	V _{CAN_L}				
Differential output voltage	V_{Diff}	V _{O(dif)}	differential output voltage		
HS-PMA static receiver input characteristics, bus biasing	active/ina	ctive			
Recessive state differential input voltage range Dominant state differential input voltage range	V _{Diff}	$V_{th(RX)dif}$	differential receiver threshold voltage		
		V _{rec(RX)}	receiver recessive voltage		
		$V_{dom(RX)}$	receiver dominant voltage		
HS-PMA receiver input resistance (matching)					
Differential internal resistance	R _{Diff}	R _{i(dif)}	differential input resistance		
Single ended internal resistance	R _{CAN_H} R _{CAN_L}	R _i	input resistance		
Matching of internal resistance	MR	ΔR_i	input resistance deviation		
HS-PMA implementation loop delay requirement					
Loop delay	t _{Loop}	t _{d(TXDH-RXDH)}	delay time from TXD HIGH to RXD HIGH		
		$t_{d(TXDL-RXDL)}$	delay time from TXD LOW to RXD LOW		
Optional HS-PMA implementation data signal timing requ Mbit/s and above 2 Mbit/s up to 5 Mbit/s	irements f	for use with bit	t rates above 1 Mbit/s up to 2		
Transmitted recessive bit width @ 2 Mbit/s / @ 5 Mbit/s, intended	t _{Bit(Bus)}	t _{bit(bus)}	transmitted recessive bit width		
Received recessive bit width @ 2 Mbit/s / @ 5 Mbit/s	t _{Bit(RXD)}	t _{bit(RXD)}	bit time on pin RXD		
Receiver timing symmetry @ 2 Mbit/s / @ 5 Mbit/s	Δt_{Rec}	Δt_{rec}	receiver timing symmetry		

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Table 12. ISO 11898-2:2016 to NXP data sheet parameter conversion...continued

ISO 11898-2:2016		NXP data sheet			
Parameter	Notation	Symbol	Parameter		
HS-PMA maximum ratings of V_{CAN_H} , V_{CAN_L} and V_{Diff}		<u>'</u>	<u>'</u>		
Maximum rating V _{Diff}	V_{Diff}	V _(CANH-CANL)	voltage between pin CANH and pin CANL		
General maximum rating V_{CAN_H} and V_{CAN_L}	V _{CAN_H}	V _x	voltage on pin x		
Optional: Extended maximum rating VCAN_H and VCAN_L	V _{CAN_L}				
HS-PMA maximum leakage currents on CAN_H and CAN	_L, unpow	ered			
Leakage current on CAN_H, CAN_L	I _{CAN_H} I _{CAN_L}	IL	leakage current		

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18 Appendix: TJx144x/TJx146x/TJF1441 family overview

Table 13. Feature overview of the complete T.Ix144x/T.Ix146x/T.IF1441 family

	Modes			Supp	lies	,	Data	rate	Additional features							
Device ^[1]	Normal	Standby	Sleep	Silent/Listen-only	Selectable Off	VCC pin	VIO pin	VBAT pin	Up to 5 Mbit/s CAN FD	Up to 8 Mbit/s CAN FD ^[2]	Signal improvement ^[3]	Wake-up source recognition ^[4]	Short WUP support [0.5 - 1.8 µs] ^[5]	Single supply pin wake-up ^[6]	TXD dominant timeout	Local diagnostics via ERR_N pin
TJx1441A	•			•		•	•		•						•	
TJx1441B	•			•		•			•						•	
TJx1441D	•			•	•	•			•						•	
TJF1441A	•			•		•	•		•						[7]	
TJx1442A	•	•				•	•		•				•	•	•	
TJx1442B	•	•				•			•				•		•	
TJx1443A	•	•	•	•		•	•	•	•			•	•	•	•	•
TJx1448A	•	•				•	•		•				•	•	•	
TJx1448B	•	•				•			•				•		•	
TJx1448C	•	•				•	•		•			•	•	•	•	
TJx1462A	•	•				•	•		•	•	•		•	•	•	
TJx1462B	•	•				•			•	•	•		•		•	
TJx1463A	•	•	•	•		•	•	•	•	•	•	•	•	•	•	•

- TJx: TJA14xxx is AEC-Q100 Grade 1; TJR14xxx is AEC-Q100 Grade 0; TJF1441A is non-automotive grade. Only guaranteed for TJA146x, AEC-Q100 Grade 1.
- CAN FD Signal Improvement Capability (SIC) according to CiA 601-4:2019.
- RXD is held LOW after wake-up request, enabling wake-up source recognition.
- WUP = wake-up pattern according ISO11898-2:2016.
- Only VIO supply needed for wake-up in TJA1442A, TJA1448A, TJA1448C, TJA1462A; only VBAT supply needed for wake-up in TJA1443A, TJA1463A.
- Not having TXD dominant timeout allows for very low data rates in non-automotive grade applications.

19 Revision history

Table 14. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
TJF1441 v.2	20211015	Product data sheet	-	TJF1441 v.1
Modifications	• Table 6: table note	e 3) and family (<u>Section 18</u>) feature 10 added timing characteristics revised	e overviews	
TJF1441 v.1	20200812	Product data sheet	-	-

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20 Legal information

20.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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